TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74HC393AP,TC74HC393AF,TC74HC393AFN

#### **Dual Binary Counter**

The TC74HC393A is a high speed CMOS 4-BIT BINARY COUNTER fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

It contains two independent counter circuits in one package, so that counting or frequency division of eight binary bits can be achieved with one IC.

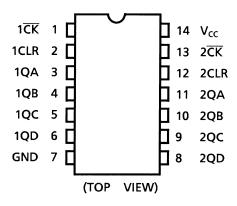
This device changes state on the negative going transition of the  $\overline{CK}$  pulse. The counter can be reset to "0" (QA to QD = "L") by a high at the CLR input regardless of other inputs.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

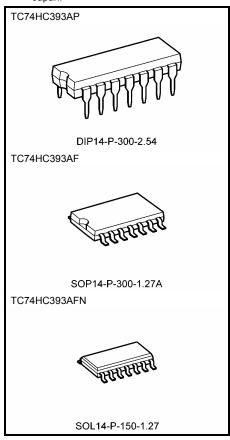
#### **Features**

- High speed:  $f_{max} = 72 \text{ MHz}$  (typ.) at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $I_{CC} = 4 \mu A \text{ (max)}$  at  $T_{a} = 25 \text{°C}$
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance: | IOH | = IOL = 4 mA (min)
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range:  $V_{CC}$  (opr) = 2 to 6 V
- Pin and function compatible with 74LS393

### **Pin Assignment**



Note: xxxFN (JEDEC SOP) is not available in Japan.



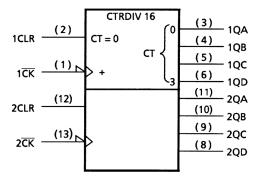
Weight

DIP14-P-300-2.54 : 0.96 g (typ.) SOP14-P-300-1.27A : 0.18 g (typ.) SOL14-P-150-1.27 : 0.12 g (typ.)

1 2007-10-01



## **IEC Logic Symbol**

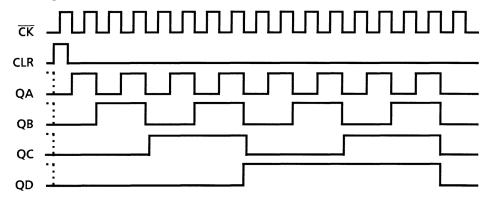


#### **Truth Table**

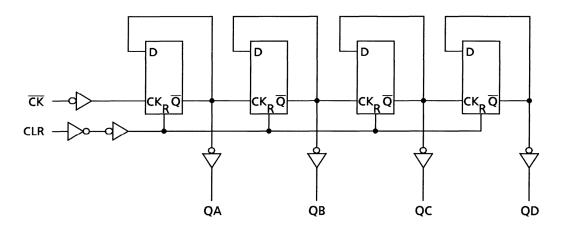
Inp	uts	Outputs							
CK	CLR	QA	QB	Q	QD				
Х	Н	L	L	L	L				
$\neg$	L	Count Up							
	L	No Change							

X: Don't care

## **Timing Chart**



## **System Diagram**





#### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	–0.5 to 7	V
DC input voltage	V <sub>IN</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
DC output voltage	V <sub>OUT</sub>	$-0.5$ to $V_{CC} + 0.5$	V
Input diode current	I <sub>IK</sub>	±20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±50	mA
Power dissipation	PD	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C shall be applied until 300 mW.

### **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2 to 6	V
Input voltage	V <sub>IN</sub>	0 to V <sub>CC</sub>	V
Output voltage	V <sub>OUT</sub>	0 to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	-40 to 85	°C
		0 to 1000 (V <sub>CC</sub> = 2.0 V)	
Input rise and fall time	t <sub>r</sub> , t <sub>f</sub>	0 to 500 (V <sub>CC</sub> = 4.5 V)	ns
		0 to 400 (V <sub>CC</sub> = 6.0 V)	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.



## **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40 to 85°C		Unit
Characteriotics	Cymbol			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Orme
		_		2.0	1.50	_	_	1.50	_	
High-level input voltage	$V_{IH}$			4.5	3.15	_	_	3.15	_	V
				6.0	4.20	—	_	4.20		
				2.0		_	0.50		0.50	
Low-level input voltage	$V_{IL}$	_		4.5	_	_	1.35	_	1.35	V
ŭ				6.0	_	_	1.80	_	1.80	
	V <sub>ОН</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		2.0	1.9	2.0	_	1.9	_	
			$I_{OH} = -20 \mu A$	4.5	4.4	4.5	_	4.4	_	
High-level output voltage				6.0	5.9	6.0	_	5.9	_	V
			$I_{OH} = -4 \text{ mA}$	4.5	4.18	4.31	_	4.13	_	
			$I_{OH} = -5.2 \text{ mA}$	6.0	5.68	5.80	_	5.63	_	
		V <sub>IN</sub>		2.0	_	0.0	0.1	_	0.1	
			$I_{OL} = 20 \ \mu A$	4.5	_	0.0	0.1	_	0.1	
Low-level output voltage	$V_{OL}$	= V <sub>IH</sub> or		6.0	_	0.0	0.1	_	0.1	V
		V <sub>IL</sub>	I <sub>OL</sub> = 4 mA	4.5	_	0.17	0.26	_	0.33	
			$I_{OL} = 5.2 \text{ mA}$	6.0	_	0.18	0.26	_	0.33	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0		_	±0.1		±1.0	μА
Quiescent supply current	Icc	VIN = VC	<sub>C</sub> or GND	6.0	_	_	4.0	_	40.0	μА

## Timing Requirements (input: $t_r = t_f = 6 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Test Condition			Ta = -40 to 85°C	Unit
			V <sub>CC</sub> (V)	Тур.	Limit	Limit	
Minimum pulse width	h. an		2.0	_	75	95	
(CK)	tw (H)	_	4.5	_	15	19	ns
(CK)	t <sub>W (L)</sub>		6.0	—	13	16	
Minimum nulae width			2.0	_	75	95	
Minimum pulse width	tw (H)	_	4.5	_	15	19	ns
(CLR)			6.0	_	13	16	
			2.0	_	25	30	
Minimum removal time	t <sub>rem</sub>	_	4.5	_	5	6	ns
			6.0	_	5	5	
			2.0	_	6	5	
Clock frequency	f	_	4.5	_	32	27	MHz
			6.0	_	38	32	



## AC Characteristics (C $_L$ = 15 pF, V $_{CC}$ = 5 V, Ta = 25 °C, input: $t_r$ = $t_f$ = 6 ns)

Characteristics	Symbol	Test Condition		Тур.	Max	Unit
Output transition time	t <sub>TLH</sub>	_	_	4	8	ns
•	t <sub>THL</sub>					
Propagation delay time	$t_{pLH}$	_		12	20	ns
(CK -QA)	t <sub>pHL</sub>	_				113
Propagation delay time	t <sub>pLH</sub>			16	31	ns
( CK -QB)	$t_{pHL}$	_		10	01	110
Propagation delay time	t <sub>pLH</sub>			21	38	ns
(CK-QC)	$t_{pHL}$	_			30	113
Propagation delay time	t <sub>pLH</sub>			25	46	ns
( CK -QD)	$t_{pHL}$	_		25	40	110
Propagation delay time	4			15	26	20
(CLR-Qn)	t <sub>pHL</sub>	_		15	20	ns
Maximum clock frequency	f <sub>max</sub>	_	35	72	_	MHz



#### AC Characteristics ( $C_L = 50$ pF, input: $t_r = t_f = 6$ ns)

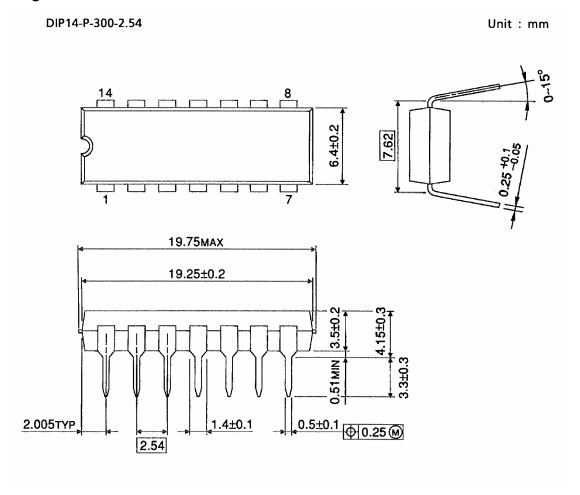
Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit
Characteristics			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic
	t <sub>TLH</sub>		2.0	_	25	75	_	95	
Output transition time	t <sub>THL</sub>	_	4.5	_	7	15	_	19	ns
	THL		6.0	_	6	13	_	16	
Propagation delay	t <sub>pLH</sub>		2.0	_	45	120	_	150	
time —	·	_	4.5	_	15	24	_	30	ns
( CK -QA)	t <sub>pHL</sub>		6.0		13	20		26	
Propagation delay	4		2.0	_	60	180	_	225	
time	t <sub>pLH</sub>	_	4.5	_	20	36	_	45	ns
( CK -QB)	t <sub>pHL</sub>		6.0	_	17	31	_	38	
Propagation delay	+		2.0	_	80	220	_	275	
time	t <sub>pLH</sub>	_	4.5	_	25	44	_	55	ns
( CK -QC)	t <sub>pHL</sub>		6.0	_	21	37	_	47	
Propagation delay	+		2.0	_	100	260	_	325	
time	t <sub>pLH</sub>	_	4.5	_	30	52	_	65	ns
( CK -QD)	t <sub>pHL</sub>		6.0	_	26	44	_	55	
Propagation delay			2.0	_	55	150	_	190	
time	t <sub>pHL</sub>	_	4.5	_	18	30	_	38	ns
(CLR-Qn)			6.0	_	15	26	_	33	
			2.0	6	22	_	5	_	
Maximum clock frequency	f <sub>max</sub>	_	4.5	32	67	_	27	_	MHz
			6.0	38	77	_	32	_	
Input capacitance	C <sub>IN</sub>	_	•	_	5	10	_	10	pF
Power dissipation	C <sub>PD</sub>	_			40				pF
capacitance	(Note)	_			70				ρi

Note: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC}$  (opr) =  $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2$  (per counter)

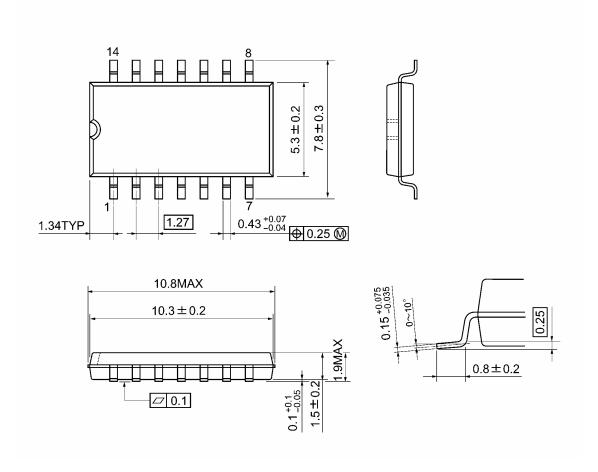
## **Package Dimensions**



Weight: 0.96 g (typ.)

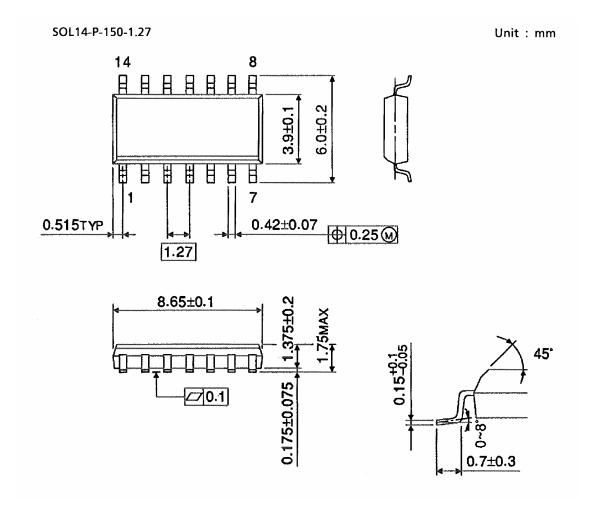
## **Package Dimensions**

SOP14-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)

## **Package Dimensions (Note)**



Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

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20070701-EN GENERAL

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